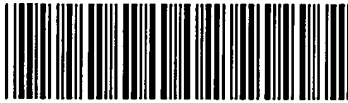


Search Notes

Application/Control No.

10/062,155

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

LIN, YU-CHUAN

Art Unit

2634

SEARCHED

Class	Subclass	Date	Examiner
375	147	8/2/2005	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM (keyword search -- see search history printout)	8/2/2005	EMF
PALM INVENTORSHIP	8/2/2005	EMF